Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/780,362	RABENKO ET AL.	
Examiner	Art Unit	
Riph O. Nauven	2664	

	SEARCHED				
Class	Subclass	Date	Examiner		
370	508	12/2/2005	BQN		
370	350	12/2/2005	BQN		
370	512	12/2/2005	BQN		
370	521	12/2/2005	BQN		
370	401	12/2/2005	BQN		
375	350	12/2/2005	BQN		
375	229	12/2/2005	BQN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (US-GPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB), see more on search history.	12/2/2005	BQN
Consulted with Andrew Lee	12/2/2005	BQN
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